IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Art Unit:

Not assigned

Yasuhiko SHIMOTSUMA et al.

Examiner: Not assigned

Serial No:

Not assigned

Filed: September 9, 2003

For:

Optical Structural Body, Its Manufacturing

Method and Optical Element

TRANSMITTAL OF INFORMATION DISCLOSURE **STATEMENT**

Mail Stop PATENT APPLICATION Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

The information disclosure statement submitted herewith is being filed concurrently with the subject application [37 C.F.R. § 1.97(b)] and contains no items of information cited in any communication from a foreign patent office in a counterpart foreign application [37 C.F.R. § 1.97(e)(1)].

If it should be determined that for any reason either an insufficient or excessive fee has been paid, please charge any insufficiency or credit any overpayment necessary to ensure consideration of the information disclosure statement for the above-identified application to Deposit Account No. 50-1314. A copy of this paper is enclosed.

By:

Respectfully submitted,

Date: September 9, 2003

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Facsimile: 213-337-6701

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FORM DTO 4	449	Dooket Number (O	Decket Number (Ontional) Application Number				
FORM PTO-1449				Docket Number (Optional) 81872.0053		Application Number Not assigned	
INFORMATION DISCLOSURE CITATION IN AN APPLICATION			Applicant Yasuhiko SHIMOTSUMA et al.				
(Use several sheets if necessary)			Filing Date September 9, 2003			Group Art Unit Not assigned	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
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FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION (YES/NO)	
	2000-193823	07/14/00	Japan			Abstract	
	2001-066428	03/16/01	Japan			Abstract	
	2001-004817	01/12/01	Japan			Abstract	
	10-282337	10/23/98	Japan			Abstract	
	11-352327	12/24/99	Japan			Abstract	
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
Toshiaki KONDO et al., "Femtosecond Laser Interference Technique with Diffractive Beam Splitter for Fabrication of Three-Dimensional Photonic Crystal", Applied Physics Letters, Vol. 79, No. 6, August 6, 2001, pp. 725-727.							
Ken-ichi Kawamura et al., "Holographic Encoding of Fine-Pitched Micrograting Structures in Amorphous SiO₂ Thin Films on Silicon by a Single Femtosecond Laser Pulse", Applied Physics Letters, Vol. 78, No. 8, February 19, 2001 pp.1038-1040							
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